查询SN54LVC138AFK供应商

捷多邦,专业PCB打SA154LV42138A急SN474LVC138A 3-LINE TO 8-LINE DECODERS/DEMULTIPLEXERS

- EPIC[™] (Enhanced-Performance Implanted **CMOS) Submicron Process**
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, $T_A = 25^{\circ}C$
- Typical VOHV (Output VOH Undershoot) > 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Inputs Accept Voltages to 5.5 V
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK) and Flat (W) Package, and DIPs (J)

description

The SN54LVC138A 3-line to 8-line decoder/ demultiplexer is designed for 2.7-V to 3.6-V V_{CC} operation and the SN74LVC138A 3-line to 8-line decoder/demultiplexer is designed for 1.65-V to 3.6-V V_{CC} operation.

The 'LVC138A devices are designed for highperformance memory-decoding or data-routing applications requiring very short propagation

delay times. In high-performance memory systems, these decoders minimize the effects of system decoding. When employed with high-speed memories utilizing a fast enable circuit, the delay times of these decoders and the enable time of the memory are usually less than the typical access time of the memory. This means that the effective system delay introduced by the decoders is negligible.

The conditions at the binary-select inputs and the three enable inputs select one of eight output lines. Two active-low enable inputs and one active-high enable input reduce the need for external gates or inverters when expanding. A 24-line decoder can be implemented without external inverters and a 32-line decoder requires only one inverter. An enable input can be used as a data input for demultiplexing applications.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

The SN54LVC138A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LVC138A is characterized for operation from -40°C to 85°C.



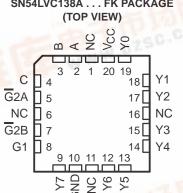
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Cisa trademark of Texas Instruments Incorporated.



Copyright © 1998, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

SCAS2911 - MARCH 1993 - REVISED OCTOBER 1998 SN54LVC138A . . . J OR W PACKAGE SN74LVC138A ... D, DB, OR PW PACKAGE (TOP VIEW) Vcc A 16 15 YO вГ С 14 Y1 3 G2A 13 Y2 4 G2B 🛛 Y3 5 12 G1 🛛 6 **1** Y4 11 10 Y5 Y7 GND [1 Y6 8 9 SN54LVC138A ... FK PACKAGE (TOP VIEW) YOC NC A B 3 2 1 20 19 С 18 Y1 G2A 17 Y2 5 NC Π6 16 NC

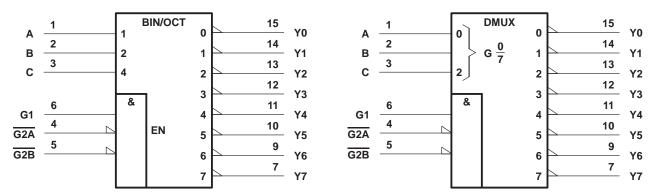


NC - No internal connection

SCAS291I – MARCH 1993 – REVISED OCTOBER 1998

	FUNCTION TABLE												
ENABLE INPUTS SELECT INPUTS				UTS				OUT	PUTS				
G1	G2A	G2B	С	В	Α	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
Х	Н	Х	Х	Х	Х	н	Н	Н	Н	Н	Н	Н	Н
X	Х	Н	Х	Х	Х	н	Н	Н	Н	Н	Н	Н	н
L	Х	Х	Х	Х	Х	н	Н	Н	Н	Н	Н	Н	н
н	L	L	L	L	L	L	Н	Н	Н	Н	Н	Н	н
н	L	L	L	L	Н	н	L	Н	Н	Н	Н	Н	н
н	L	L	L	Н	L	н	Н	L	Н	Н	Н	Н	н
н	L	L	L	Н	Н	н	Н	Н	L	Н	Н	Н	н
н	L	L	н	L	L	н	Н	Н	Н	L	Н	Н	н
н	L	L	н	L	Н	н	Н	Н	Н	Н	L	Н	н
н	L	L	н	Н	L	н	Н	Н	Н	Н	Н	L	н
н	L	L	н	Н	Н	н	Н	Н	Н	Н	Н	Н	L

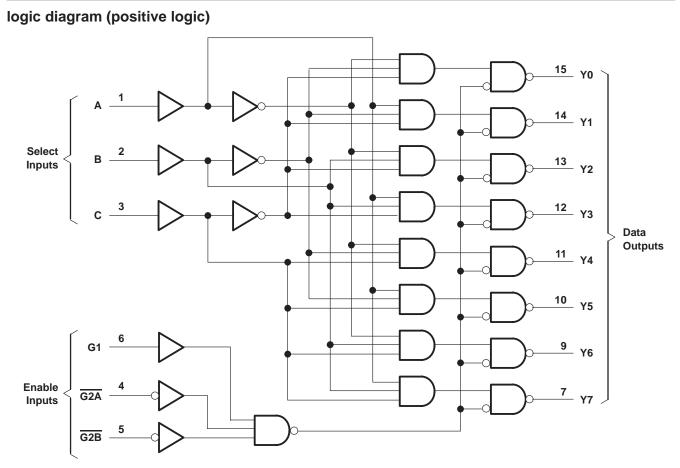
logic symbols (alternatives)[†]



[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, PW, and W packages.



SCAS2911 - MARCH 1993 - REVISED OCTOBER 1998



Pin numbers shown are for the D, DB, J, PW, and W packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	-0.5 V to 6.5 V
Input voltage range, V _I (see Note 1)	
Output voltage range, V _O (see Notes 1 and 2)	–0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} (V _I < 0)	
Output clamp current, I _{OK} (V _O < 0)	
Continuous output current, I _O	±50 mA
Continuous current through V_{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3): D package	113°C/W
DB package	
PW package	
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The value of V_{CC} is provided in the recommended operating conditions table.

3. The package thermal impedance is calculated in accordance with JESD 51.



SCAS291I - MARCH 1993 - REVISED OCTOBER 1998

recommended operating conditions (see Note 4)

			SN54LVC138A		SN74LV	/C138A		
		Γ	MIN	MAX	MIN	MAX	UNIT	
	Cumple und the me	Operating	2	3.6	1.65	3.6	V	
VCC	Supply voltage	Data retention only	1.5		1.5	3.6	v	
		V _{CC} = 1.65 V to 1.95 V			$0.65 \times V_{CC}$			
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V			1.7		V	
		V _{CC} = 2.7 V to 3.6 V	2		2	MAX 3.6 0.35 × V _{CC} 0.7 0.8 5.5 V _{CC} −4		
		V _{CC} = 1.65 V to 1.95 V				$0.35 \times V_{CC}$		
VIL	Low-level input voltage	V _{CC} = 2.3 V to 2.7 V				0.7	V	
		V _{CC} = 2.7 V to 3.6 V		0.8		0.8		
VI	Input voltage		0	5.5	0	5.5	V	
Vo	Output voltage		0	VCC	0	VCC	V	
		V _{CC} = 1.65 V				-4		
1	Lich lovel output outpot	V _{CC} = 2.3 V				-8	mA	
ЮН	High-level output current	V _{CC} = 2.7 V		-12		$\begin{array}{c} 0.35 \times V_{CC} \\ 0.7 \\ 0.8 \\ 5.5 \\ V_{CC} \\ -4 \\ -8 \\ -12 \\ -24 \\ 4 \\ 8 \\ 12 \\ 24 \end{array}$		
		$V_{CC} = 3 V$		-24				
		V _{CC} = 1.65 V				4		
1	I and local and and an end	V _{CC} = 2.3 V				8		
IOL	Low-level output current	V _{CC} = 2.7 V		12		12	mA	
		$V_{CC} = 3 V$		24		24	1	
$\Delta t / \Delta v$	Input transition rise or fall rate		0	10	0	10	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



SCAS2911 - MARCH 1993 - REVISED OCTOBER 1998

	TEST CONDITIONS		SN54	LVC138	A	SN74LVC138A				
PARAMETER	TEST CONDITIONS	vcc	MIN	TYP†	MAX	MIN	TYP†	MAX	UNI	
	100	1.65 V to 3.6 V				V _{CC} -0.2				
	I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} -0.2							
	$I_{OH} = -4 \text{ mA}$	1.65 V				1.2				
VOH	I _{OH} = -8 mA	2.3 V				1.7			V	
	I _{OH} = -12 mA	2.7 V	2.2			2.2				
	OH = -12 MA	3 V	2.4			2.4				
	I _{OH} = -24 mA	3 V	2.2			2.2				
	100	1.65 V to 3.6 V						0.2	v	
	I _{OL} = 100 μA	2.7 V to 3.6 V			0.2					
	I _{OL} = 4 mA	1.65 V						0.45		
VOL	I _{OL} = 8 mA	2.3 V						0.7		
	I _{OL} = 12 mA	2.7 V			0.4			0.4		
	I _{OL} = 24 mA	3 V			0.55			0.55		
Ц	$V_{I} = 5.5 V \text{ or GND}$	3.6 V			±5			±5	μA	
ICC	$V_I = V_{CC} \text{ or } GND, I_O = 0$	3.6 V			10			10	μA	
ΔICC	One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND	2.7 V to 3.6 V			500			500	μA	
Ci	$V_{I} = V_{CC}$ or GND	3.3 V		5			5		рF	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

				SN54LV	/C138A		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
			MIN	MAX	MIN	MAX	
	A or B or C			7.9	1	6.7	
tpd	G2A or G2B	Y		7.4	1	6.5	ns
	G1			6.4	1	5.8	

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

		TO (OUTPUT)	SN74LVC138A							
PARAMETER	FROM (INPUT)		V _{CC} = 1.8 V	= V _{CC} ± 0.2	2.5 V 2 V	V _{CC} = 2.7 V		$\begin{array}{c} V_{\textbf{CC}} = 3.3 \ V \\ \pm \ 0.3 \ V \end{array}$		UNIT
			TYP	MIN	MAX	MIN	MAX	MIN	MAX	
	A or B or C	Y	15.9	1	9.9		7.9	1	6.7	6.7
^t pd	G2A or G2B		15.4	1	9.4		7.4	1	6.5	ns
	G1		14.4	1	8.4		6.4	1	5.8	
^t sk(o) [‡]									1	ns

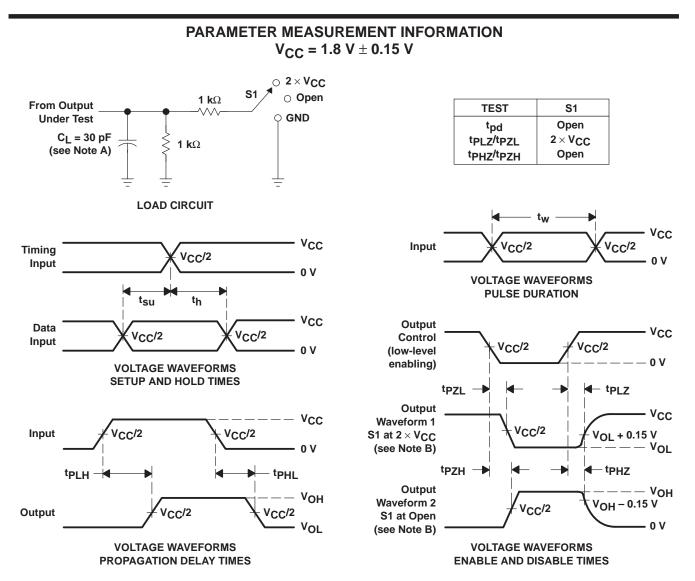
[‡] Skew between any two outputs of the same package switching in the same direction



SCAS291I - MARCH 1993 - REVISED OCTOBER 1998

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER		TEST	V _{CC} = 1.8 V	V _{CC} = 2.5 V	V _{CC} = 3.3 V	UNIT
		CONDITIONS	TYP	TYP	TYP	UNIT
Cpd	Power dissipation capacitance	f = 10 MHz	25	26	27	pF



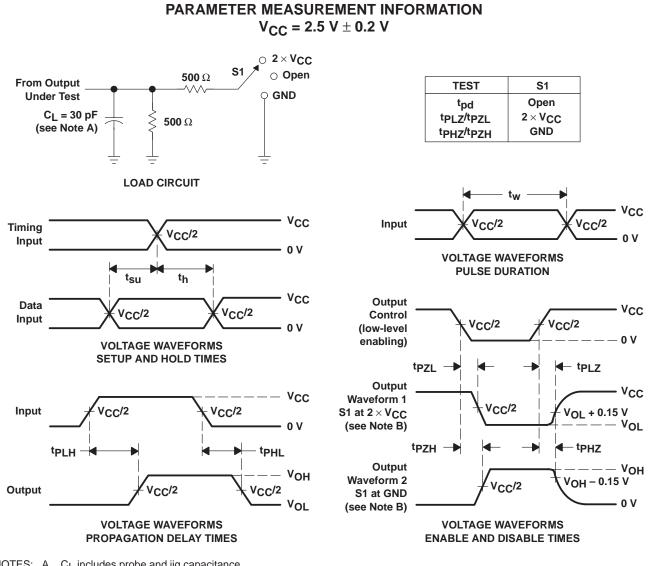
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_Q = 50 Ω, t_f ≤ 2 ns, t_f ≤ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tPLH and tPHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



SCAS291I - MARCH 1993 - REVISED OCTOBER 1998



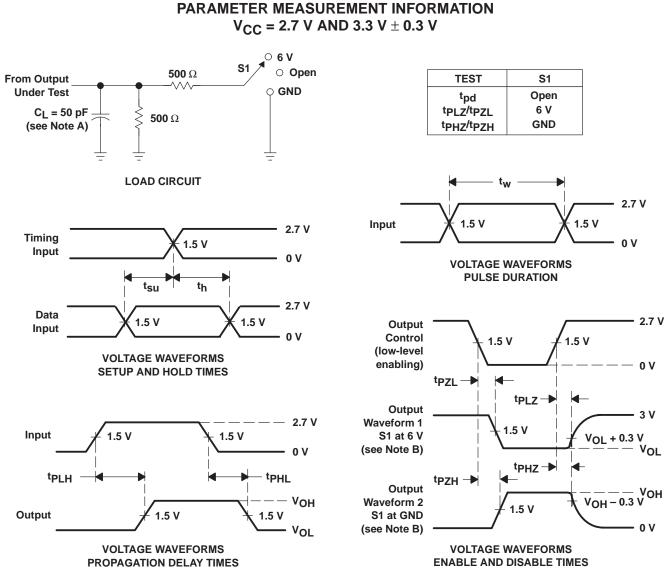
NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



SCAS2911 - MARCH 1993 - REVISED OCTOBER 1998



NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns. t_f \leq 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 3. Load Circuit and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated